1 5 8 9 5 1 44 - GAU: 2877

Receipt date: 08/15/2006

## JAPE Rec'd PCT/PTO 15 AUG 2006

## S/N Filed Herewith

PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

GIGLIO et al.

Examiner:

Unknown

Serial No.:

Filed Herewith

Group Art Unit:

Unknown

Filed:

August 15, 2006

Docket No.:

09728.0389USWO

Title:

A METHOD FOR MEASURING PROPERTIES OF PARTICLES BY

MEANS OF INTERFERENCE FRINGE ANALYSIS AND

CORRESPONDING APPARATUS

CERTIFICATE UNDER 37 CFR 1.10:

"Express Mail" mailing label number: EV 840126496 US Date of Deposit: August 15, 2006

I hereby certify that this paper or fee is being deposited with the U.S. Postal Service "Express Mail Post Office to Addressee" service under 37 CFR 1.10 on the date indicated above and is ad tessed to: Mail Stop PCT, Commissioner for

Patents, P.O. Box 1450, Alexandria, Virginia 22313-1450.

INFORMATION DISCLOSURE STATEMENT (37 C.F.R. § 1.97(b))

Mail Stop PCT Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Dear Sir:

With regard to the above-identified application, the items of information listed on the enclosed Form 1449 are brought to the attention of the Examiner. Enclosed for the Examiner's information is a copy of the International Search Report. At least some of the references were recently cited in an International Search Report mailed July 14, 2005.

This statement should be considered because it is submitted within three months of the filing date of the above-identified application, which is not an application under 37 C.F.R. § 1.53(d). Accordingly, no fee is due for consideration of the items listed on the enclosed Form 1449.

A copy of any foreign patent document or "Other Document" listed on the Form 1449 is enclosed, in accordance with 37 C.F.R. §1.98(a)(2). Because this application was filed after June 30, 2003, copies of the U.S. Patents and U.S. patent publications listed on the enclosed Form 1449 are not provided.

Receipt date: 08/15/2006

No representation is made that a reference is "prior art" within the meaning of 35 U.S.C. §§ 102 and 103 and Applicants reserve the right, pursuant to 37 C.F.R. § 1.131 or otherwise, to establish that the reference(s) are not "prior art." Moreover, Applicants do not represent that a reference has been thoroughly reviewed or that any relevance of any portion of a reference is intended.

Consideration of the items listed is respectfully requested. Pursuant to the provisions of M.P.E.P. 609, it is requested that the Examiner return a copy of the attached Form 1449, marked as being considered and initialed by the Examiner, to the undersigned with the next official communication.

Please charge any additional fees or credit any overpayment to Deposit Account No. 13-2725.

Respectfully submitted,

MERCHANT & GOULD P.C.

P.O. Box 2903

Minneapolis, MN 55402-0903

(612)332.5300

Dated: August 15, 2006

23552

Reg. No.: 33,280

GAS/mkc

Receipt date: 08/15/2006

(Use several sheets if necessary)

13 Rec'd PCT/PTQ 01 50 AUG 2010: 2877

Group Art Unit: Unknown

ste Mailed: August 15, 2006			Sheet I of I			
FORM 1449*	INFORMATION DISCLOSURE STATEMENT	Docket Number: 09728.0389USWO	Application Number: 89514			
	IN AN APPLICATION	Applicant: GIGLIO et al.				

Filing Date: August 15, 2006

			U.S. PATENT DOCUME	NTS					
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE			
	5,327,217	7/1994	Kanai et al.						
	-	-							
	I	FO	REIGN PATENT DOCUM	4ENTS					
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION			
						YES	NO		
	02/103332 A2	12/2002	WIPO						
		· · · · · ·							
<del></del> .	OTHER	DOCUMENT	'S (Including Author, Title,	Date. Pertinent I	Pages Etc.)				
	Brogioli,		odyne near-field scattering,:			1(22): 4109-	1111,		
	Glover, A sparse spi	Glover, A.R. et al. "Interferometric laser imaging for droplet sizing: a method for droplet-size measurement in sparse spray systems," APPLIED OPTICS, 34(26): 8409-8421, December 20, 1995							
	Kreuzer,	Kreuzer, H.J. et al. "Digital in-line holography," EUROPHYSICS NEWS, 34(2), March/April 2003							
			Recognition with a Digital OPTICS, 41(20): 4108-411			n Partially Co	herent		

23552

EXAMINER /Scott Richev/ DATE CONSIDERED 08/11/2009